

Automated Test Equipment (ATE) for EV Battery Management Systems (BMS): Challenges and Solutions

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Overview

- Battery pack and Battery Management Systems (BMS): Critical component of EV
- BMS and BMS-ATE: Key functions and challenges
- Proposed BMS-ATE Solution
 - System architecture and modes of operation
 - Parametric Measurement Unit (PMU) based architecture
 - PMU measured results
- Future trends
- Conclusion

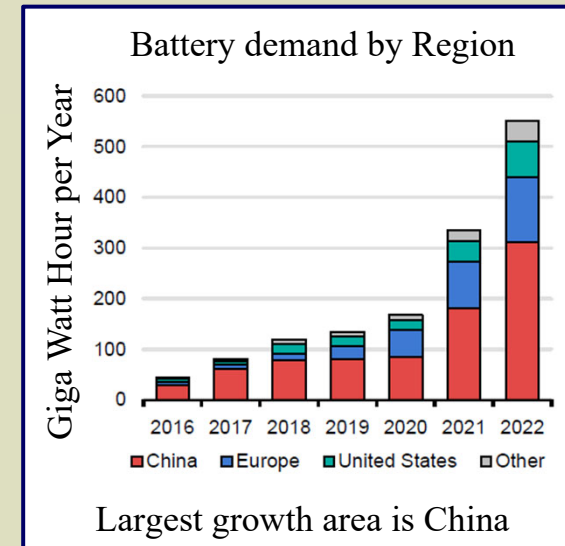


Automated Test Equipment (ATE) for EV Battery Management Systems (BMS): Challenges and Solutions



EV Battery Pack: The New “Fuel Tank”

- Exponential growth in EVs driven by consumer adoption and government mandates
- Battery pack critical to EV safety, reliability and range
 - Multiple electric cars, trucks, tuk tuk and motorcycles on the market!
- Largest growth area is China
 - Motivates discussion at TestConX China

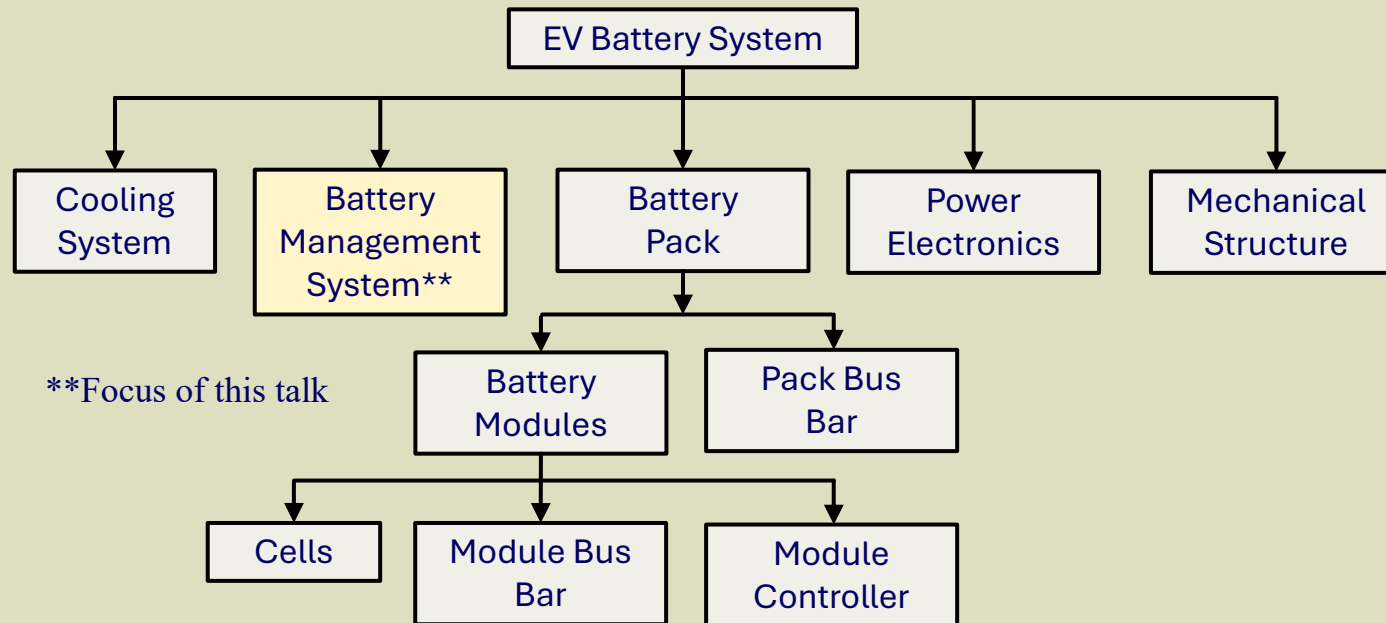


Automated Test Equipment (ATE) for EV Battery Management Systems (BMS): Challenges and Solutions



EV Battery Pack System Architecture

- EV battery-pack ~ 400V to 800V: Series connection of ~ 16 battery modules
- Each Battery module : (16 to 24 cells in series) X (70 to 100 cells in parallel)
- Each battery module has a dedicated BMS IC

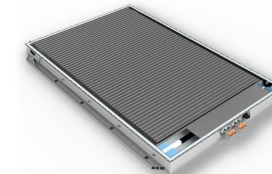


**Focus of this talk

Example EV Battery Systems
Tesla Model S



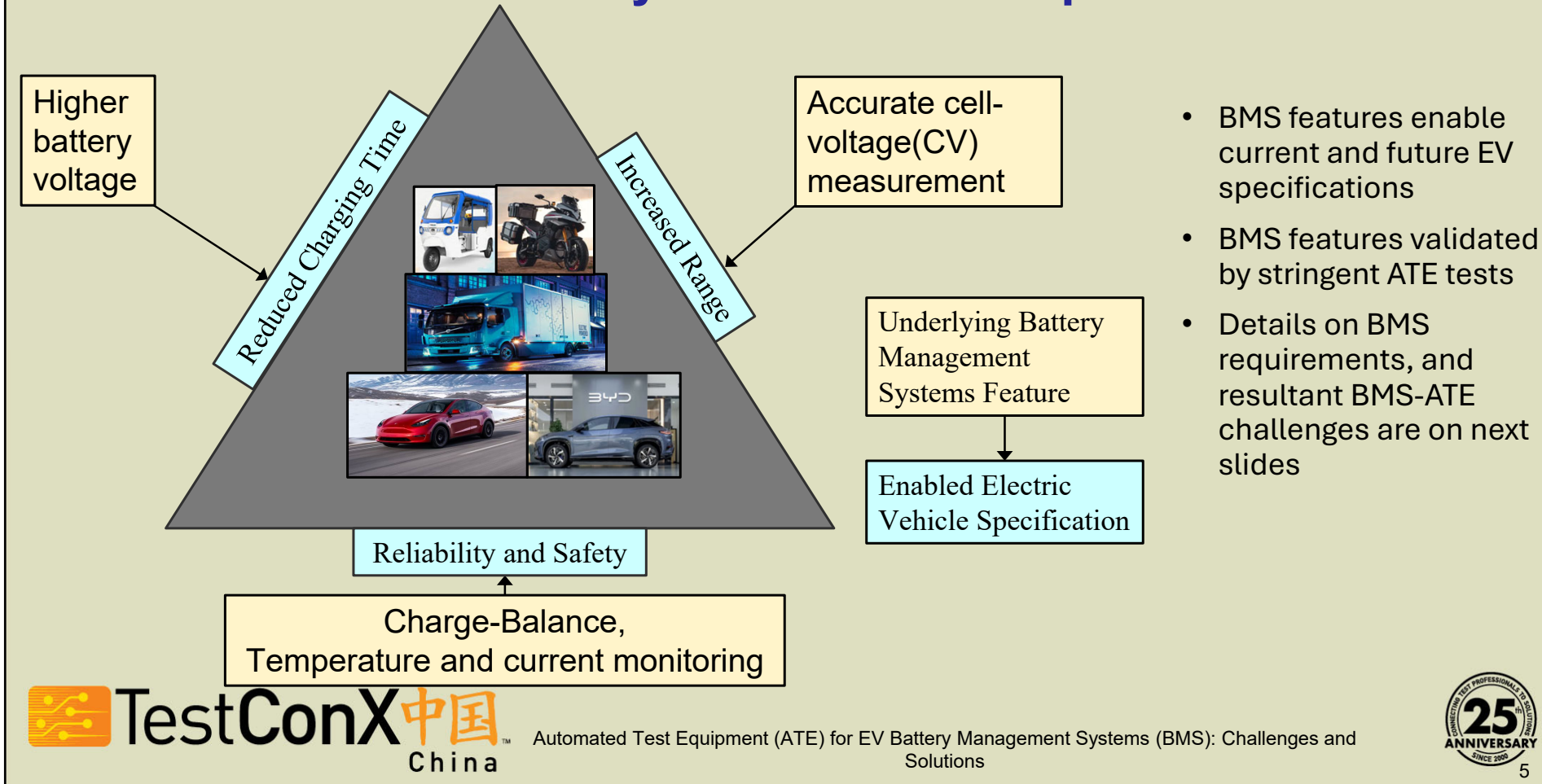
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BMS Features: Key Enabler of EV Specifications



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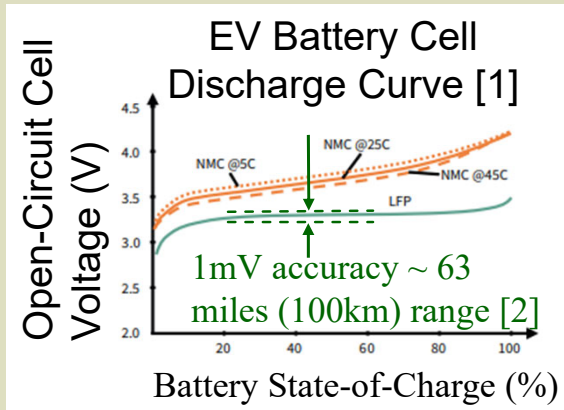


Automated Test Equipment (ATE) for EV Battery Management Systems (BMS): Challenges and Solutions



BMS & BMS-ATE requirements for accurate cell-voltage measurement

- EV battery State-of-Charge (SoC) needs measurement of each cell-voltage
- EV battery cells have very flat discharge curves
 - BMS : Need accurate Analog-to-Digital Converters (ADCs) for cell-voltage measurement
 - ~100s microVolt precision needed to accurately calculate EV range
 - BMS-ATE : Automated-Test Equipment (ATE) needs accurate Digital-to-Analog Converters (DACs) to generate stimuli outputs for test of BMS ADC capabilities
 - ❖ BMS-ATE needs low-noise, high-linearity DAC and analog-front end (AFE)

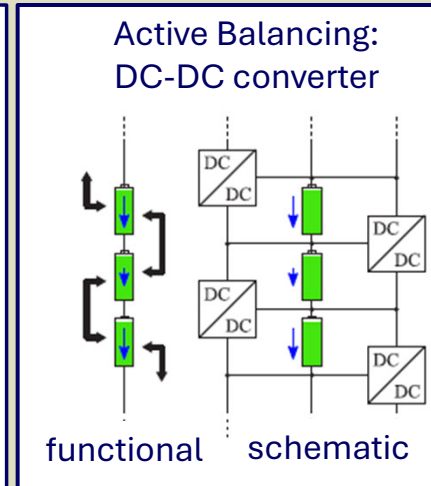
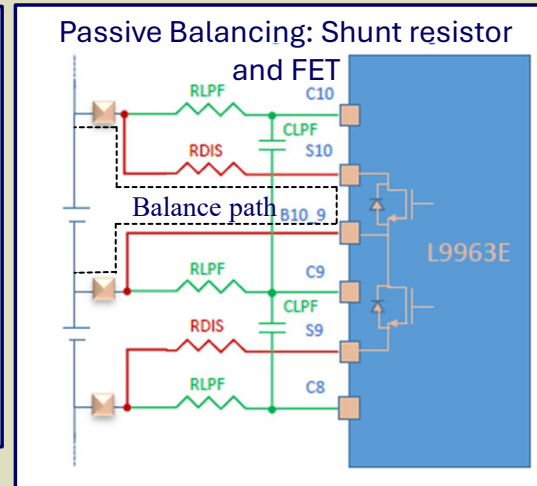
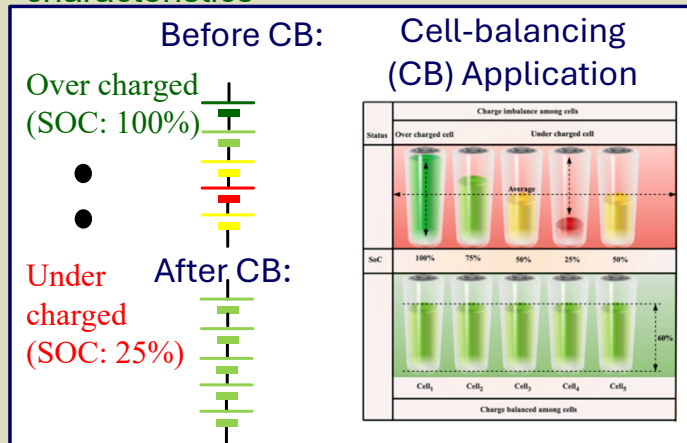


Parameter	BMS IC		
	ADI	TI	ST
Cell Voltage Measurement	ADBMS6830B	BQ79616	L9963E
LSB Resolution (uV)	150	190	89

[1] Infineon-INF1197_ART_BMS_Whitepaper_d08-Whitepaper-v01_00-EN.pdf
 [2] A new battery management system could boost EV range by 20 percent | Ars Technica

BMS & BMS-ATE requirements for EV battery Cell Balancing

- Series connected cells have different SoC due to differences in manufacturing, ageing and operational conditions
 - Over-charging and deep-discharging battery cells may lead to safety hazards
- Hence, BMS balance the series State-of-Charge (SoC)
 - Current method : Passive balancing: Shunt resistor to dissipate extra charge.
 - Low complexity, but generates heat and has low power efficiency
 - Next generation: Active cell-balancing: DC-to-DC converters which redistribute charge
- BMS-ATE requirements: (1) Measure internal / external discharge FETs, (2) Emulate small-signal battery cell characteristics

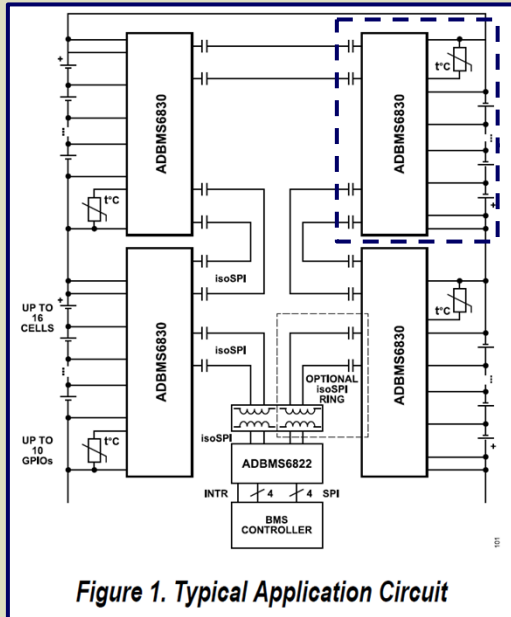


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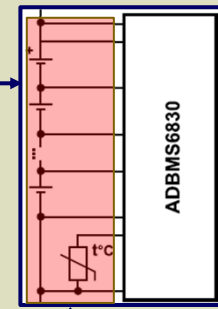


Challenges of BMS-ATE

- Example BMS Application Circuit:**
 Analog Devices ADBMS6830 16-Channel Multicell Battery Monitor
- Series stack of 4 battery modules
 - 1 BMS IC per battery module



Zoom-in on one BMS-DUT



ATE hardware emulates Battery Cells

BMS-ATE needs to be high-precision, low-noise and highly-linear to accurately test BMS features:

BMS features ATE needs to test:	Required ATE-HW-features to implement test:
300uV or more accurate Analog-Front-End (AFE) and ADCs for battery Cell-voltage measurement	30-300uV accurate voltage sources
1uA or more accurate input-current	300nA – 1uA accurate current measurement capabilities
Battery temperature-sensing	Accurate I/V source and measurement capability

Additional challenges of BMS-ATE:

1. Need high channel-density, while testing 16 or higher cells
2. Series battery stack connection needs BMS to source high common-mode voltages

Overview

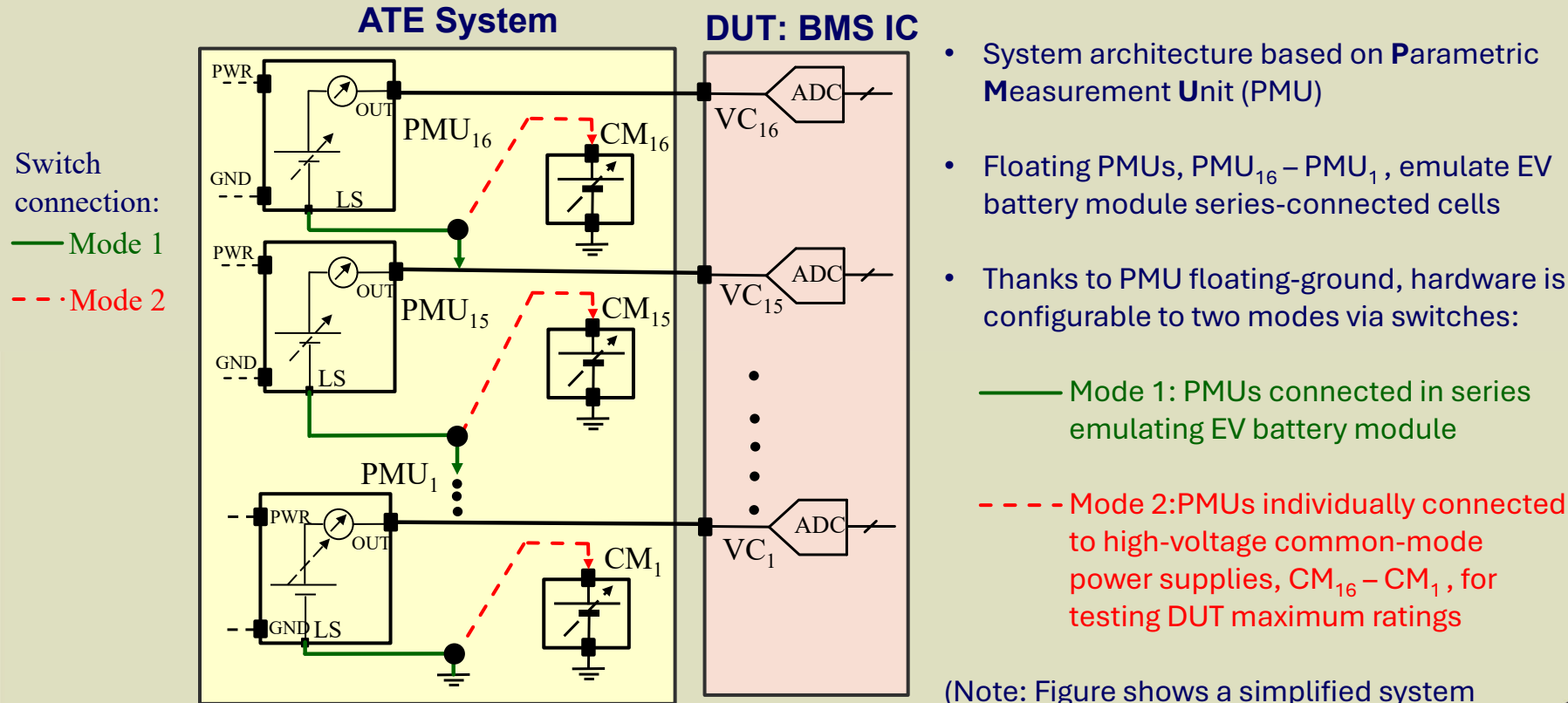
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- **Proposed BMS-ATE Solution**
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Proposed system solution for BMS-ATE: Reconfigurable stack of PMU



- System architecture based on **Parametric Measurement Unit (PMU)**
- Floating PMUs, $PMU_{16} - PMU_1$, emulate EV battery module series-connected cells
- Thanks to PMU floating-ground, hardware is configurable to two modes via switches:

— Mode 1: PMUs connected in series emulating EV battery module

- - - Mode 2: PMUs individually connected to high-voltage common-mode power supplies, $CM_{16} - CM_1$, for testing DUT maximum ratings

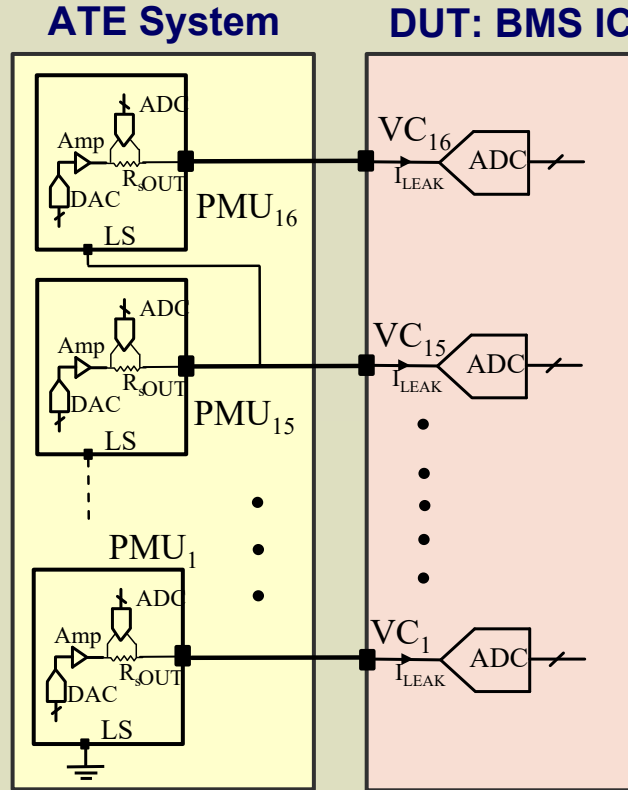
(Note: Figure shows a simplified system architecture for 16-series-cell BMS ATE)



Automated Test Equipment (ATE) for EV Battery Management Systems (BMS): Challenges and Solutions



BMS-ATE test (1): Measure Cell-Voltage ADC and Leakage



- DUT Specifications under test:
 - $CV_{16} - CV_1$: BMS channel Cell voltage Measurement LSB Resolution (μV)
 - $I_{LEAK_{16}} - I_{LEAK_1}$: BMS channel Input Leakage (nA)
- Typical DUT Specification Value:

Parameter	BMS IC		
	ADI	TI	ST
	ADBMS6830B	BQ79616	L9963E
Cell Voltage Measurement			
LSB Resolution (μV)	150	190	89
Input Leakage (nA)	250	100	300

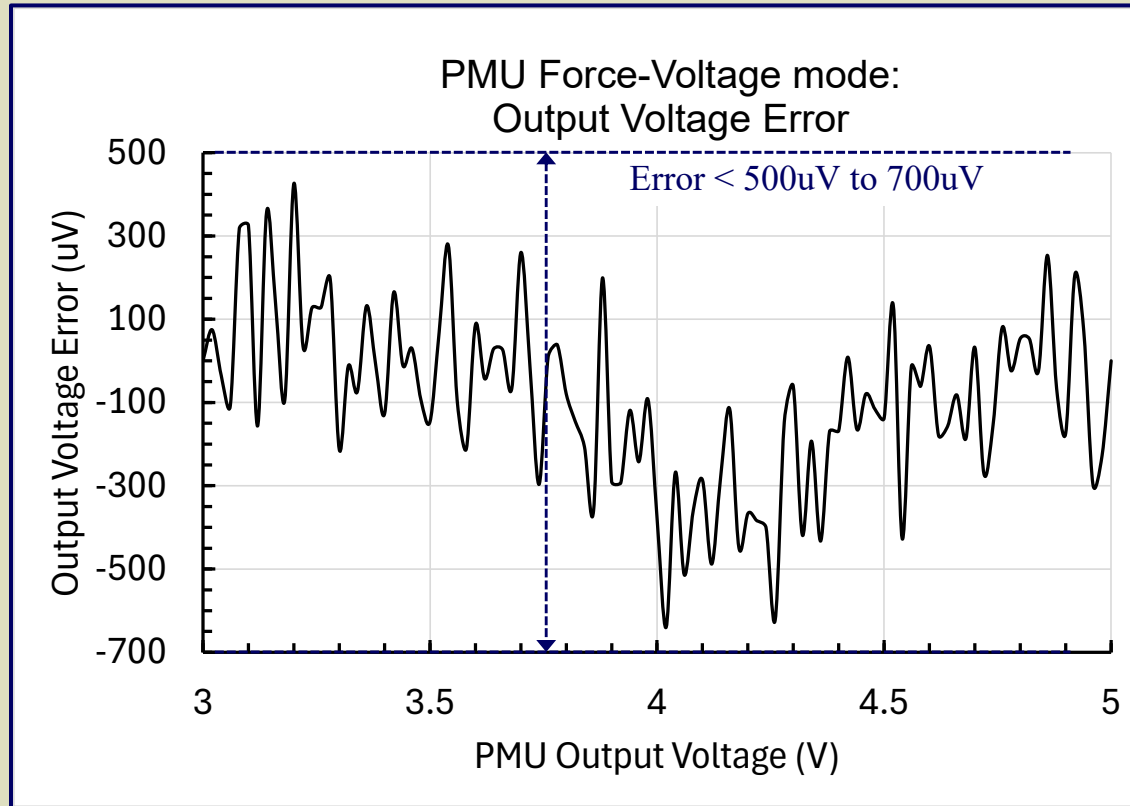
- ATE Test Method: ATE emulates battery cells
 1. Test program sets DAC input digital code, e.g., 20-bit 0x87AF4
 2. PMU outputs set voltage to DUT VC terminal, e.g., 3.89765V
 3. Test program records:
 - a. ADC cell-voltage measured by DUT
 - b. ADC leakage current measured by PMU



Automated Test Equipment (ATE) for EV Battery Management Systems (BMS): Challenges and Solutions

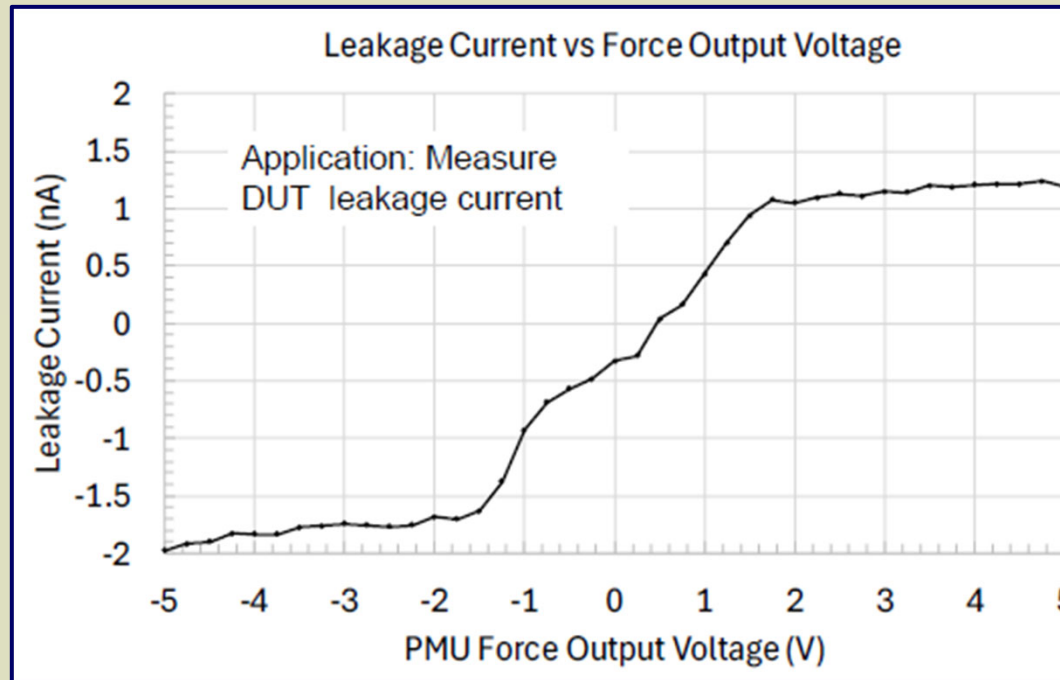


BMS-ATE test (1): Measured Elevate PMU Precision Force-Voltage



- PMU-Based ATE configuration:
 - PMU configured to drive BMS DUT with operational battery cell voltage, e.g., 3V to 5V
 - Accuracy of Forced-Voltage is within 500 μV to 700 μV (Can be further improved by system calibration)
- Applications:
 - Measure BMS-DUT cell-voltage resolution for state-of-charge determination

BMS-ATE test (1): Measured Elevate PMU ultra-low leakage current



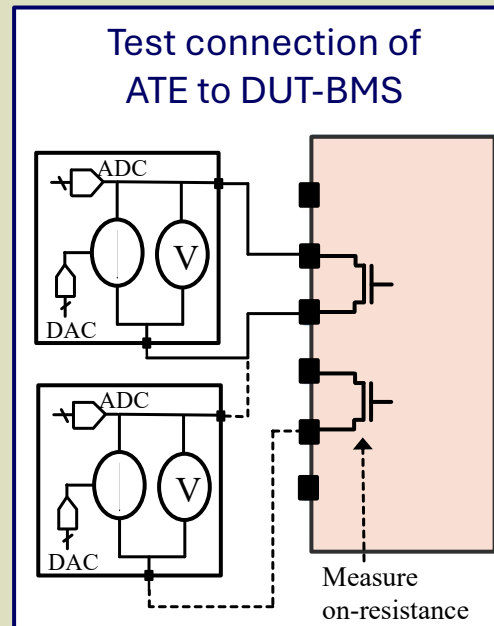
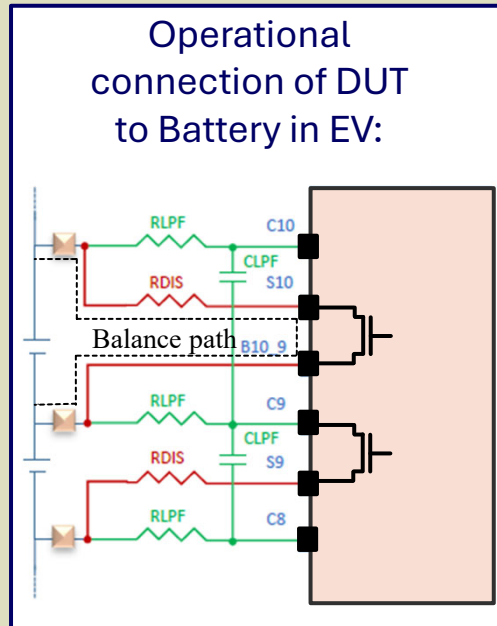
- DUT Specification-under-Test:
 - Input Leakage Current

Parameter	BMS IC		
	[4] ADBMS6830B	[5] BQ79616	[6] L9963E
Input Leakage (nA)	250	100	300

- PMU-Based ATE configuration:
 - PMU can be configured to drive BMS DUT with operational battery cell voltage, e.g., 3V to 5V
 - PMU leakage current is within +/-2nA, indicating accurate measurement of DUT leakage current

BMS-ATE test (2): Measure cell balancing FET On-Resistance (Ron)

- DUT Specifications under test:
 - R_{ON} : BMS charge balancing On Resistance (Ω)



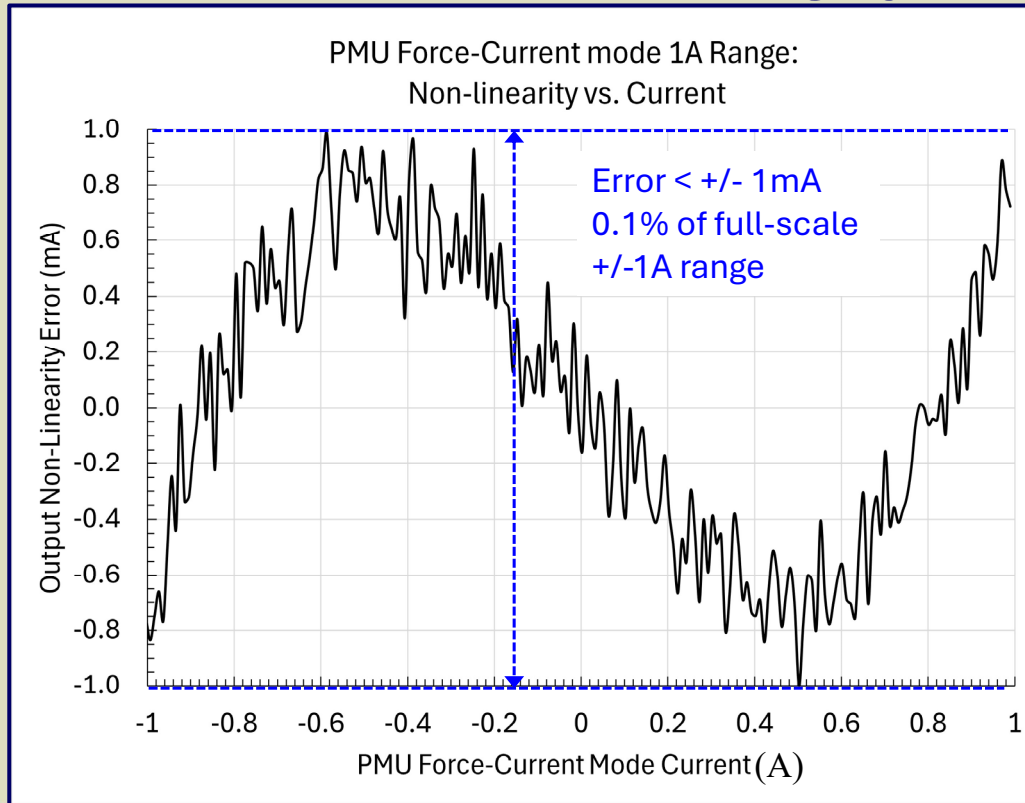
- Typical DUT Specification Value:

Parameter	BMS IC		
	[4] ADBMS6830B	[5] BQ79616	[6] L9963E
Maximum Charge Balancing FET On Resistance (Ω)	4	4.6	1.5

- ATE Test Method: ATE emulates battery cells
 - Test program sets DAC input digital code
 - PMU outputs set current, I_{FORCE} to DUT charge-balance terminal, e.g., 100mA
 - Test program records measurements :
 - PMU ADC voltage across charge-balance FET
 - Test program calculates:

$$R_{ON} = V_{ADC} / I_{FORCE}$$

BMS-ATE test (2): Measured Elevate PMU Highly Linear 1Ampere Force-Current



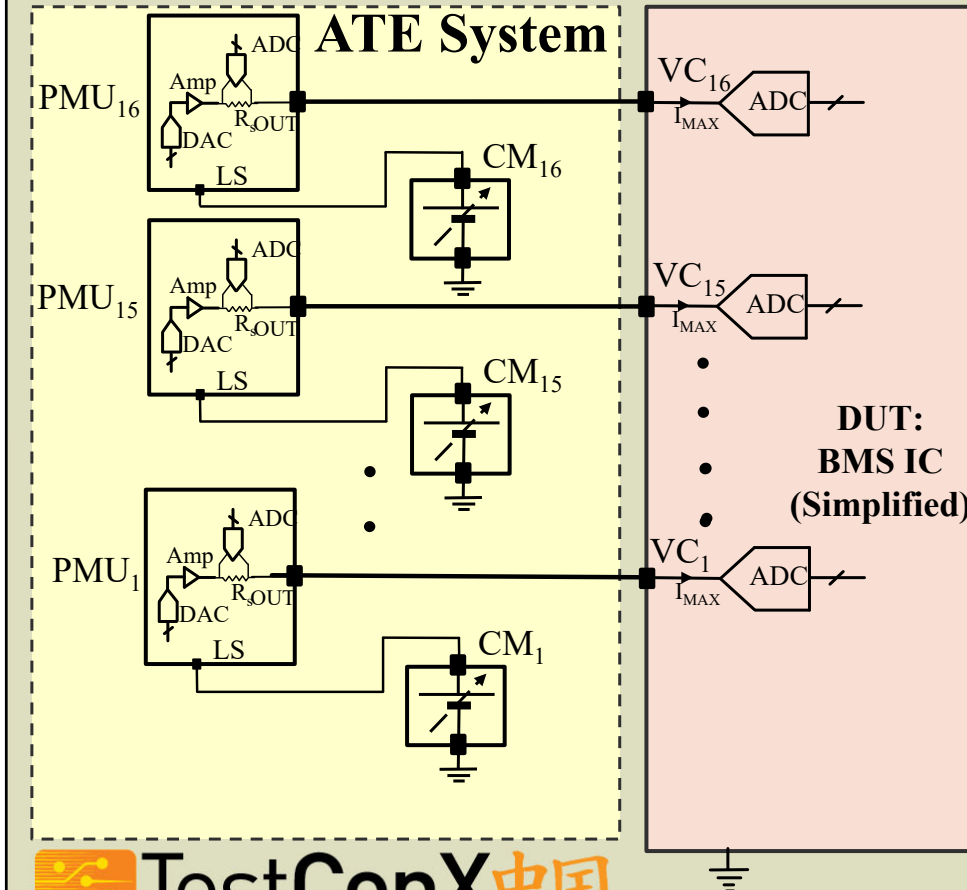
- PMU-Based ATE configuration:
 - Large-signal current as high as +/- 1A can be forced into DUT from ATE
 - Accuracy is within 0.1%, or +/- 1mA
 - Note: Part supports ganging of several PMUs in parallel to source higher current into the DUT
- Applications:
 - Accurate measurements of BMS charge-balance FET on-resistance with run-time-level 1 Ampere current



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BMS-ATE test (3): Test DUT Maximum Rating



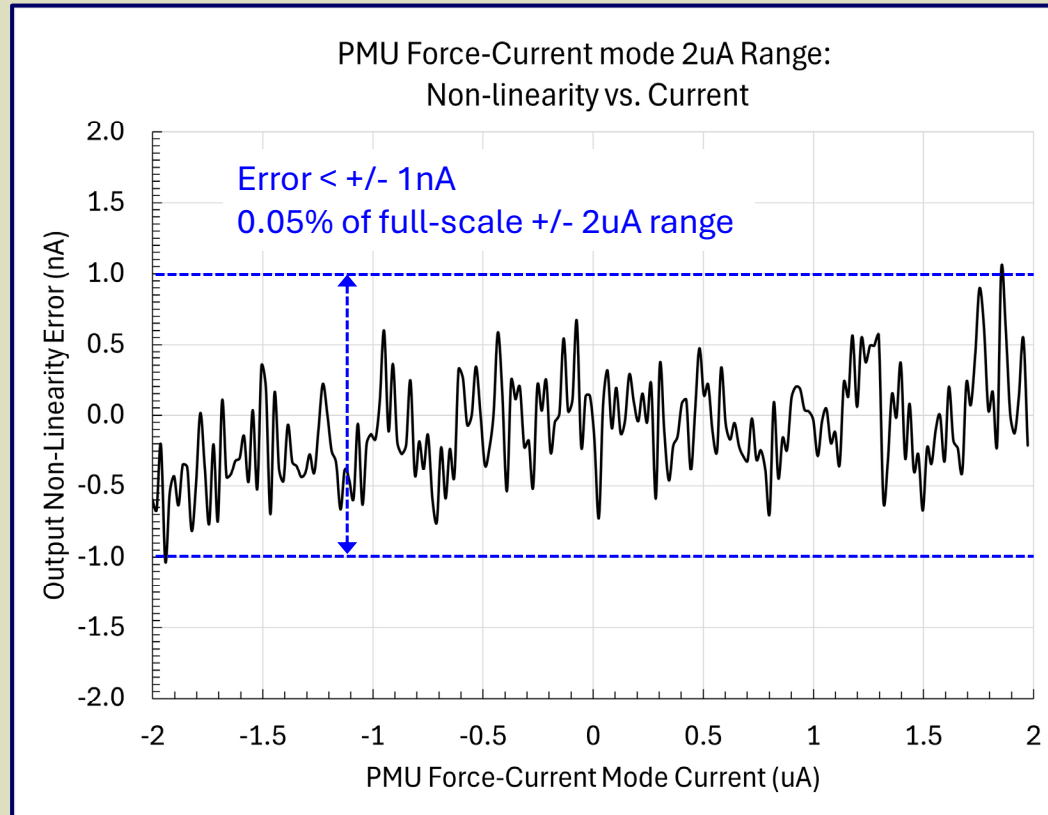
- DUT Specifications under test:
 - $V_{MAX16} - V_{MAX1}$: BMS maximum rated voltage
 - $I_{MAX16} - I_{MAX1}$: BMS current at maximum rated voltage

- Typical DUT Specification Value:

Parameter	BMS IC		
	ADI ADBMS6830B	TI BQ79616	ST L9963E
Maximum Rated Voltage (V)	-0.3V to 85V	-0.3V to 100V	-0.3V to 72V

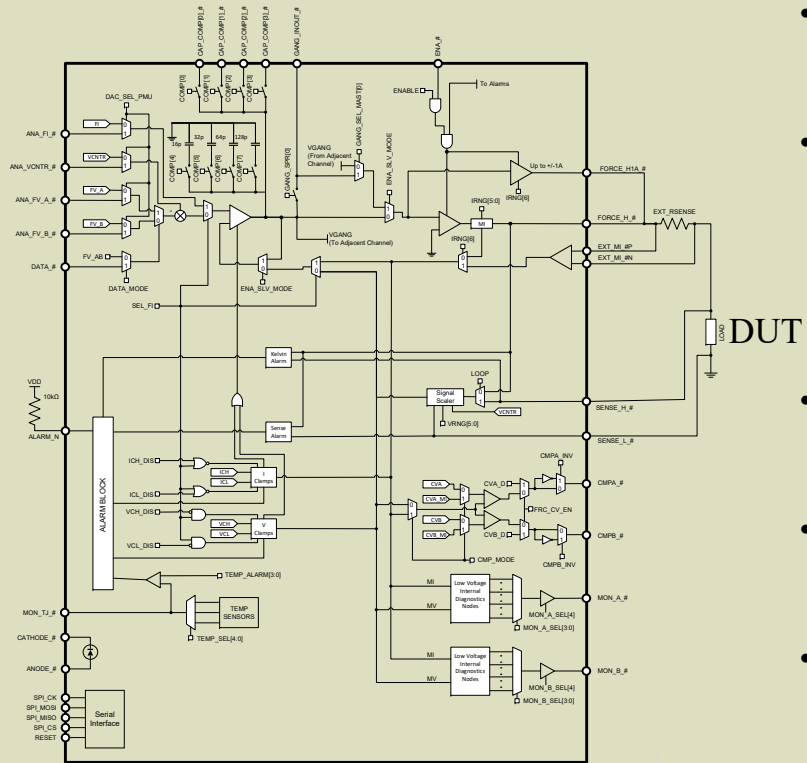
- ATE Test Method: ATE emulates battery cells
 - Test program configures PMU to be connected in series with common-mode supply
 - Test program sets output voltage per maximum DUT specification
 - Test program measures DUT current and checks compliance vs. specification

Measured Elevate PMU: Ultra-Low Micro-Ampere force-current



- PMU-Based ATE configuration:
 - Small-signal current as low as +/- 2uA can be forced into DUT from ATE
 - Accuracy is within 0.05%, or +/- 1nA
- Applications:
 - Small-signal current-mode testing of the BMS-DUT

Elevate PMU ASIC High-Level Architecture



- Integrated DACs drive BMS-DUT Cell-Voltage and Charge-Balance and Bus-Bar terminals
- Multi-mode operation:
 - Force-voltage
 - Force-current
 - Measure-voltage
 - Measure-current
- High-dynamic range from micro-Ampere to Ampere, with 0.1% precision
- Test BMS-DUT Cell-Voltage resolution, input-current, balance-FET and other capabilities
- Integrated clamps with alarms for fault detection:
 - Temperature
 - Over-voltage
 - Over-current
 - Kelvin fault detection



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BMS Future Trends

- Increased EV Range which needs higher-voltage battery-packs, higher precision, active cell management and active cell balance
- EV Battery aging, state-of-charge and state-of-health tracking via electrochemical impedance spectroscopy
- EV cell-to-pack or module-free design
- ElevATE PMU roadmap intercepts these trends with 120V PMU, high-resolution DACs and small-signal analog-front-end under feasibility evaluation



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Conclusion

- EVs have proliferated the commercial mass-market
 - Continue to experience exponential growth
- BMS are key driver of EV safety, reliability and range
- Both current performance and future-trend of BMS critically depends on ATE
 - BMS is only as good as it is **designed tested by ATE**
 - Yet, BMS-ATE has many challenges
- ElevATE System and PMU-IC solution to BMS-ATE challenges has been presented
 - Configurable and scalable across battery-architecture, EV design, and future-trends



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